

AO4486

100V N-Channel MOSFET

General Description

The AO4486 combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{\text{DS(ON)}}$. This device is ideal for boost converters and synchronous rectifiers for consumer, telecom, industrial power supplies and LED backlighting.

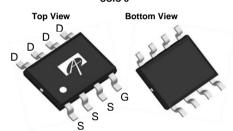
Product Summary

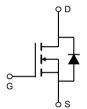
 $\begin{array}{lll} V_{DS} & 100V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & 4.2A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & <79 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 4.5V) & <90 m\Omega \end{array}$

100% UIS Tested 100% R_g Tested









Absolute Maximum Ratings T_A=25°C unless otherwise noted

Parameter		Symbol Maximum		Units	
Drain-Source Voltage		V _{DS}	100	V	
Gate-Source Voltage		V _{GS}	±20	V	
Continuous Drain Current	T _A =25°C		4.2		
	T _A =70°C	I _D	3.4	A	
Pulsed Drain Current ^C		I _{DM}	31		
Avalanche Current ^C		I _{AS} , I _{AR}	14	A	
Avalanche energy L=0.1mH ^C		E _{AS} , E _{AR}	10	mJ	
	T _A =25°C	В	3.1	W	
Power Dissipation ^B	T _A =70°C	$-P_{D}$	2	VV	
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	°C	

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	D	31	40	°C/W			
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	59	75	°C/W			
Maximum Junction-to-Lead	Steady-State	$R_{\theta JL}$	16	24	°C/W			



Electrical Characteristics (T_{.1}=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units		
STATIC PARAMETERS									
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V		100			V		
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =100V, V _{GS} =0V				1	μА		
						5			
I _{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} = ±20V				±100	nA		
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_D=250\mu A$		1.6	2.2	2.7	V		
$I_{D(ON)}$	On state drain current	V_{GS} =10V, V_{DS} =5V		31			Α		
R _{DS(ON)}	Static Drain-Source On-Resistance	V_{GS} =10V, I_D =3A			62.5	79	mΩ		
		T _J i	=125°C		121	151	11122		
		V_{GS} =4.5V, I_D =3A			68.5	90	mΩ		
g _{FS}	Forward Transconductance	V_{DS} =5V, I_{D} =3A			20		S		
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.74	1	V		
Is	Maximum Body-Diode Continuous Current					3.5	Α		
DYNAMIC	PARAMETERS								
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =50V, f=1MHz		620	778	942	pF		
Coss	Output Capacitance			38	55	81	pF		
C _{rss}	Reverse Transfer Capacitance			13	24	35	pF		
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		0.7	1.45	2.2	Ω		
SWITCHI	NG PARAMETERS								
Q _g (10V)	Total Gate Charge	V _{GS} =10V, V _{DS} =50V, I _D =3.0A		13	16.3	20	nC		
Q _g (4.5V)	Total Gate Charge			6.4	8.1	10	nC		
Q_{gs}	Gate Source Charge			2.2	2.8	3.4	nC		
Q_{gd}	Gate Drain Charge			2.4	4.1	5.8	nC		
t _{D(on)}	Turn-On DelayTime				6		ns		
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =50V, R_L =16.7 Ω , R_{GEN} =3 Ω			2.5		ns		
t _{D(off)}	Turn-Off DelayTime				21		ns		
t _f	Turn-Off Fall Time				2.4		ns		
t _{rr}	Body Diode Reverse Recovery Time	I _F =3A, dI/dt=500A/μs		14	21	28	ns		
Q_{rr}	Body Diode Reverse Recovery Charge	I _F =3A, dI/dt=500A/μs		65	94	123	nC		

A. The value of R_{BJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The value in any given application depends on the user's specific board design.

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B. The power dissipation P_D is based on $T_{J(MAX)}$ =150° C, using \leq 10s junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150° C. Ratings are based on low frequency and duty cycles to keep initialT₁=25° C.

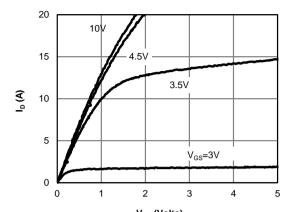
D. The R_{NJA} is the sum of the thermal impedence from junction to lead R_{NJL} and lead to ambient. E. The static characteristics in Figures 1 to 6 are obtained using <300 μ s pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedence which is measured with the device mounted on 1in² FR-4 board with

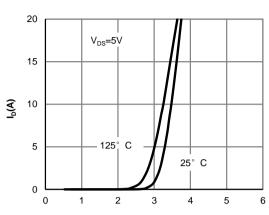
²oz. Copper, assuming a maximum junction temperature of T_{J(MAX)}=150° C. The SOA curve provides a single pulse rating.



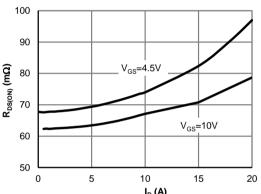
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



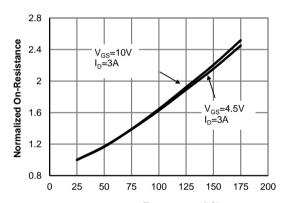
V_{DS} (Volts) Fig 1: On-Region Characteristics (Note E)



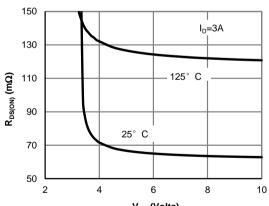
V_{GS}(Volts)
Figure 2: Transfer Characteristics (Note E)



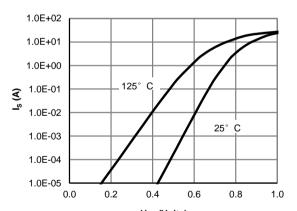
 $\label{eq:ldot} {\rm I_D}\left({\rm A}\right)$ Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)



Temperature (°C)
Figure 4: On-Resistance vs. Junction Temperature
(Note E)



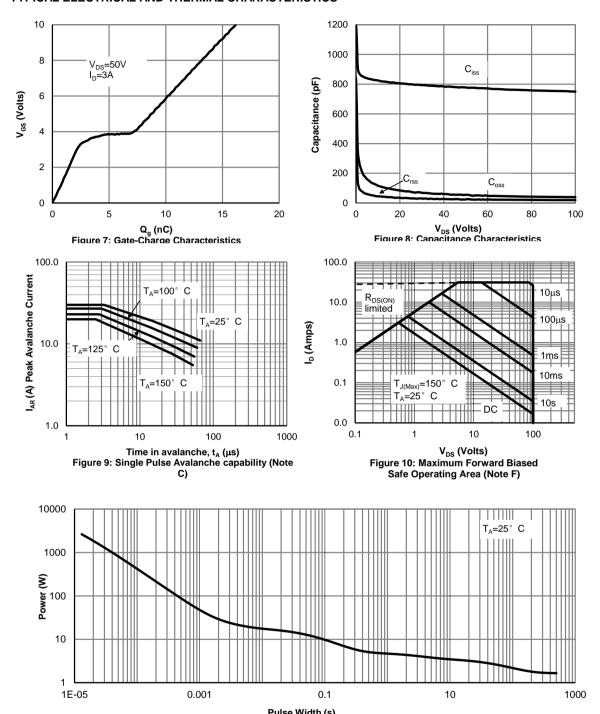
V_{GS} (Volts)
Figure 5: On-Resistance vs. Gate-Source Voltage
(Note E)



V_{SD} (Volts) Figure 6: Body-Diode Characteristics (Note E)



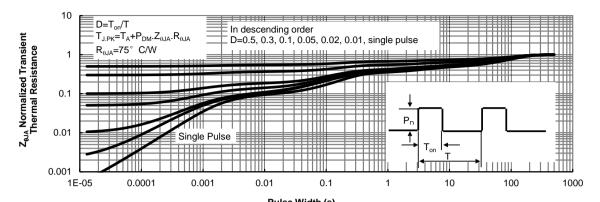
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Pulse Width (s)
Figure 11: Single Pulse Power Rating Junction-to-Ambient (Note F)



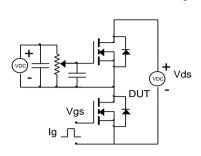
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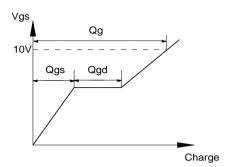


Pulse Width (s)
Figure 12: Normalized Maximum Transient Thermal Impedance (Note F)

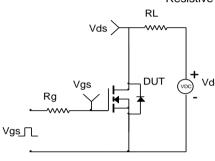


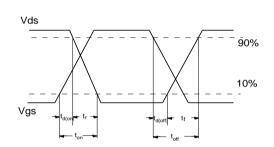
Gate Charge Test Circuit & Waveform



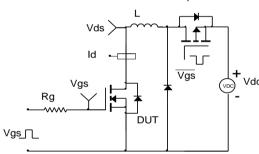


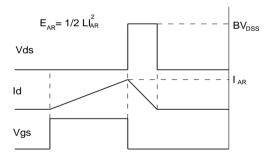
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

